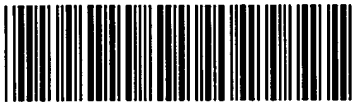


Search Notes

Application/Control No.

10/501,287

Examiner

Tsz K. Chiu

Applicant(s)/Patent under
Reexamination

LOPEZ ET AL.

Art Unit

2822

SEARCHED

Class	Subclass	Date	Examiner
438	116	1/4/2006	TKC
438	113	1/4/2006	TKC
438	465	1/4/2006	TKC
438	558	1/4/2006	TKC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
EAST (text search see attach)		1/4/2006	TKC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (text search see attach)	1/4/2006	TKC
Discussed with Primary examiner Michael Trinh	1/4/2006	TKC